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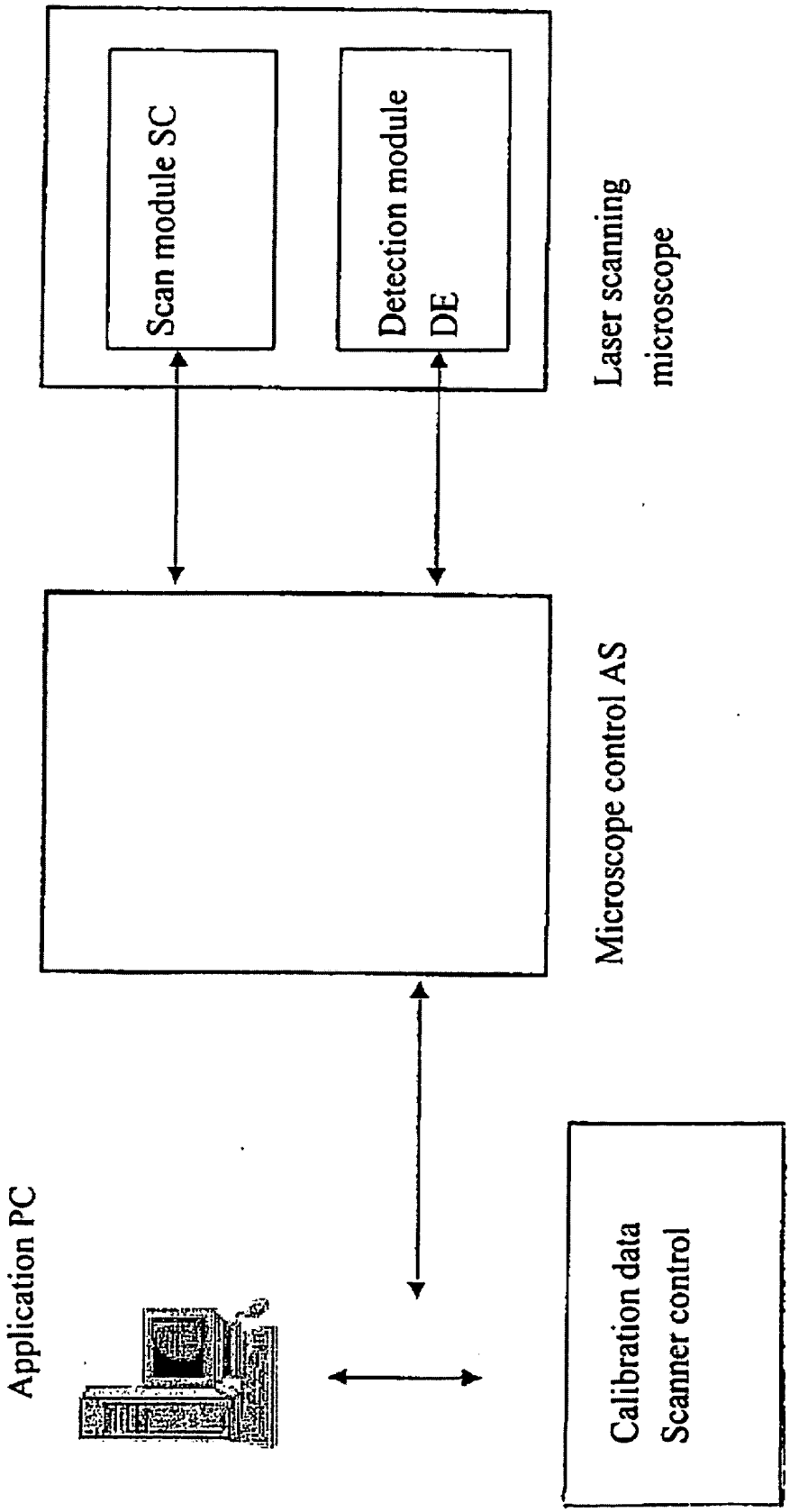

FIGURE 1

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FIGURE 2a

Correlation of partial images of the forward or back scan in the x scanner direction (example cross-grid sample, for example 20 μm grid):

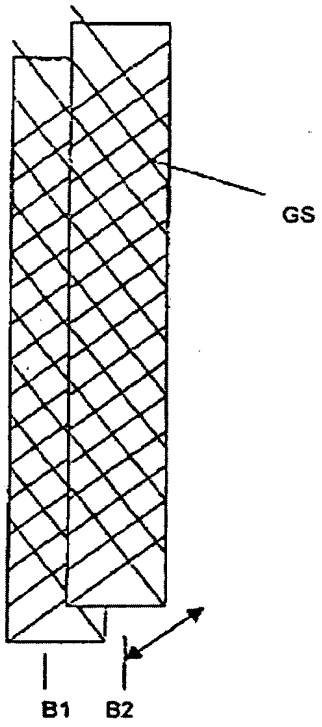

FIGURE 2b

Correlation in the y scanner direction:

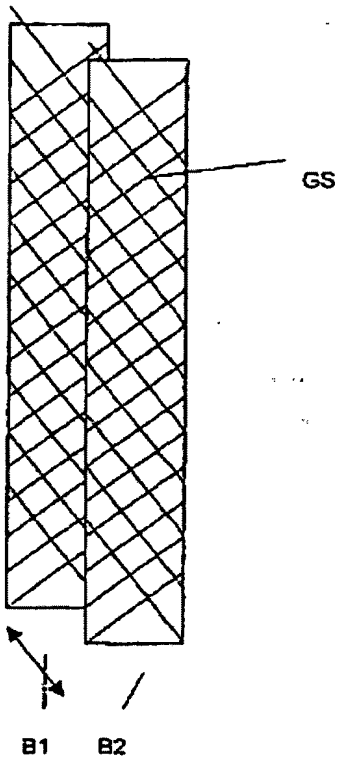

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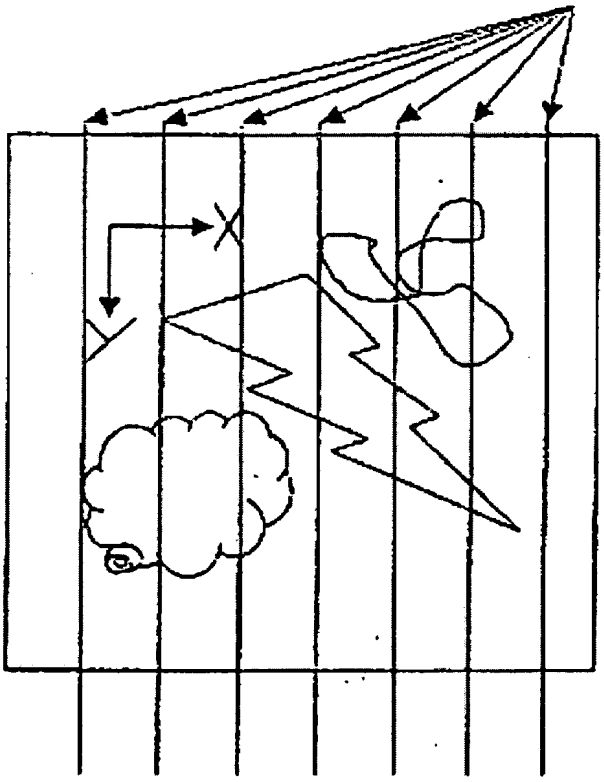
FIGURE 3

Slice direction for the strips



Displacement direction to
determine the error of the X scanner

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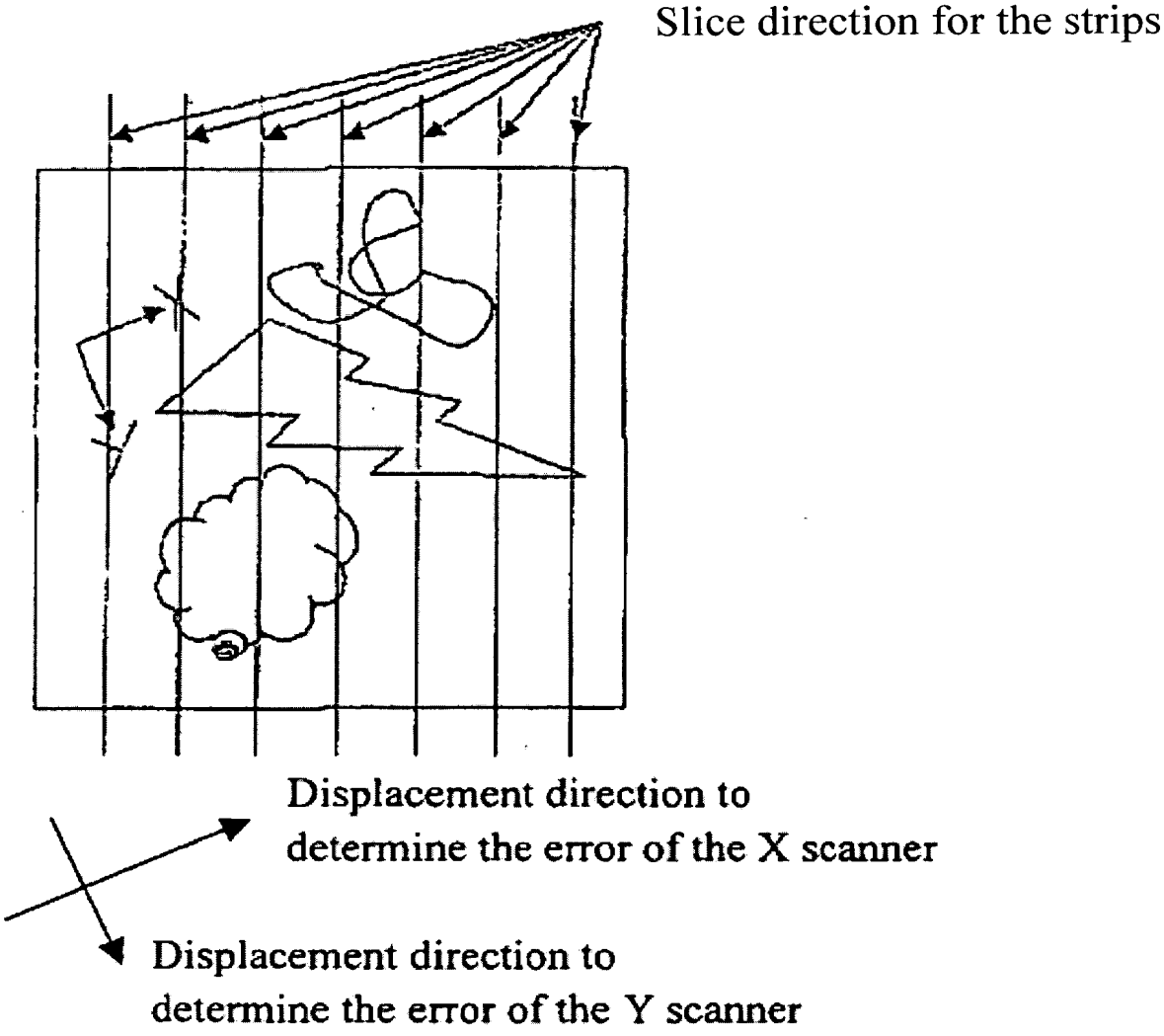
FIGURE 4